

10/02 U.S. PTO
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U.S. UTILITY Patent Application

PATENT NUMBER and
ISSUE DATE

APPL NUM 10042929	FILING DATE 10/18/2001	CLASS 378	SUBCLASS 71	GAU 2882	EXAMINER Hoon Song
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INVENTORS: Newman Janet; de La Fortelle Eric;

HKS

**CONTINUING DATA VERIFIED:

THIS APPLN CLAIMS BENEFIT OF 60/242,034 10/19/2000 HKS

FOREIGN APPLICATIONS VERIFIED:

HKS

PG-PUB DO NOT PUBLISH ☐

RESCIND ☐

Foreign priority claimed

☐ yes ☒ no

35 USC 119 conditions met

☐ yes ☒ no

Verified and Acknowledged Examiner's initials

HKS

ATTORNEY DOCKET NO

10342-0010-999

TITLE: Apparatus and method for identification of crystals by in-situ X-ray diffraction

U.S. DEPT. OF COM. / PAT & TM-PTO-459 (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Hoon Song Assistant Examiner	
ISSUE FEE		DRAWING	
Amount Due	Date Paid	Total Claims 37	Print Claim for O.G. 1
		Sheets Drawn 6	Figs Drawn 7
		Print Fig. 1	
<input checked="" type="checkbox"/> TERMINAL DISCLAIMER		Primary Examiner	
		Application Examiner	
		PREPARED FOR ISSUE	
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